 earch Notes		

Application No.	Applicant(s)	
10/768,662	ABE ET AL.	
Examiner	Art Unit	
John T. Kwon	3747	

	SEAR	CHED	
Class	Subclass	Date	Examiner
123	672		
701	109		
	114		

INTERFERENCE SEARCHED		
Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	:	DATE	EXMR
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